Notice of References Cited Application/Control No. 09/770,116 Examiner Robert D. Harlan Applicant(s)/Patent Under Reexamination DUAN, JIWEN F. Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	Α	US-			
	В	US-			
	С	US-			
	D	US-			
	Ε	US-			,
	F	US-			
	G	US-			
	Н	US-			
	-	US-			
	J	US-			
	К	US-			
	L	US-			
	Mi	US-	-		

FOREIGN PATENT DOCUMENTS

*	,	Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
*	N	WO 99/28033	10-1999	PCT	Ridland et al.	·
*	0	EP 1 016 741 A1	07-2000	EPO	Kato et al.	·
	Р					
	Q		*			
	R					
	S	*				
	Т					

NON-PATENT DOCUMENTS

**		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	ŧ V	
	w	
	х	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.